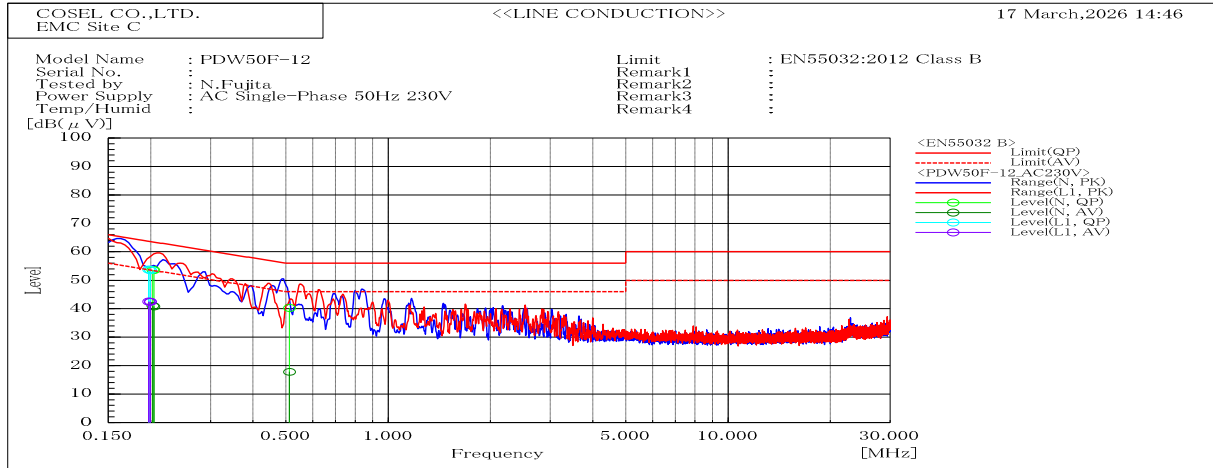
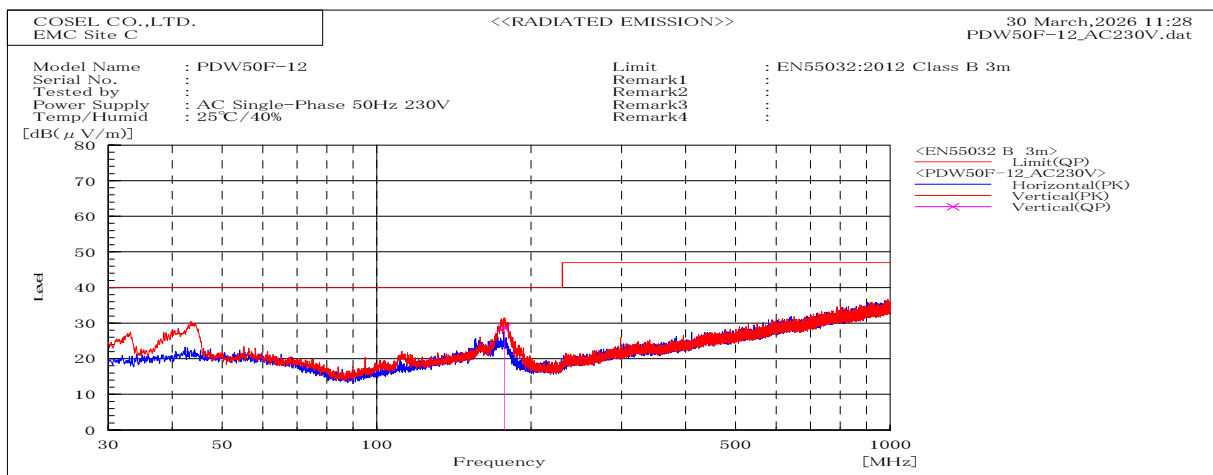


DATA SHEET		Date	11-Apr-26
Model	PDW50F-12	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



Frequency MHz	Line	Level dB(μ V)		Limit dB(μ V)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.197	L1	53.8	42.6	63.7	53.7	9.9	11.1	Pass	
0.199	L1	53.7	42.5	63.6	53.6	9.9	11.1	Pass	
0.2	L1	53.5	42.4	63.6	53.6	10.1	11.2	Pass	
0.203	N	53.7	41	63.5	53.5	9.8	12.5	Pass	
0.204	N	53.6	40.8	63.4	53.4	9.8	12.6	Pass	
0.512	N	40.3	17.8	56	46	15.7	28.2	Pass	

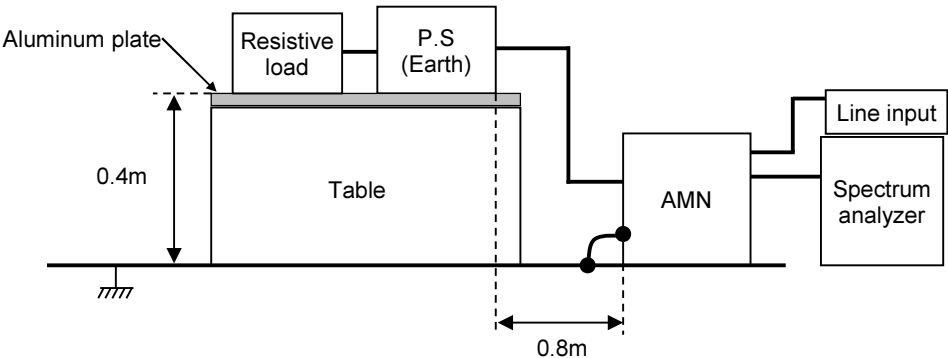


Frequency MHz	Polarization	Stability	Level dB(μ V/m)		Limit dB(μ V/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV						
177.268	V	Stable	28.6	40	40	11.4	Pass	100	259.4	

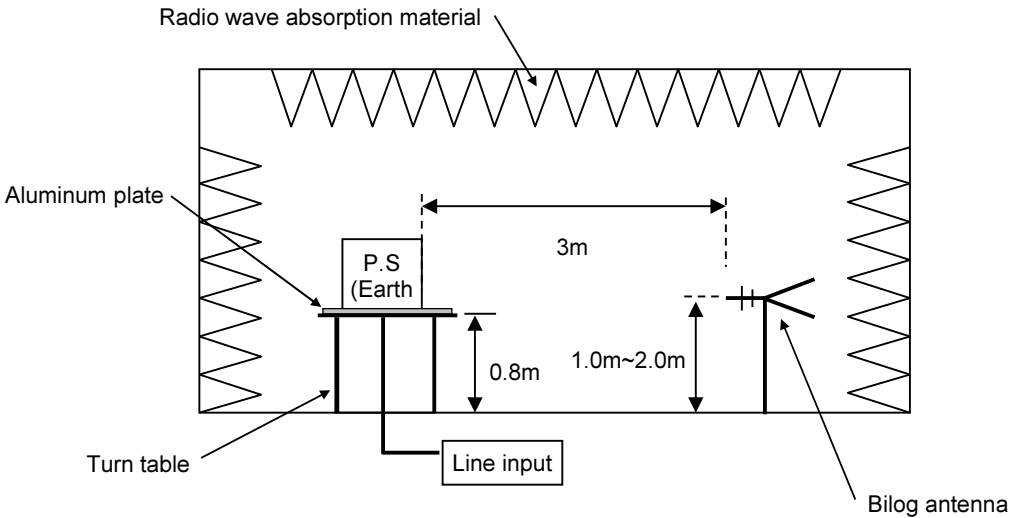


DATA SHEET		Date	11-Apr-26
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



2. Radiated emission

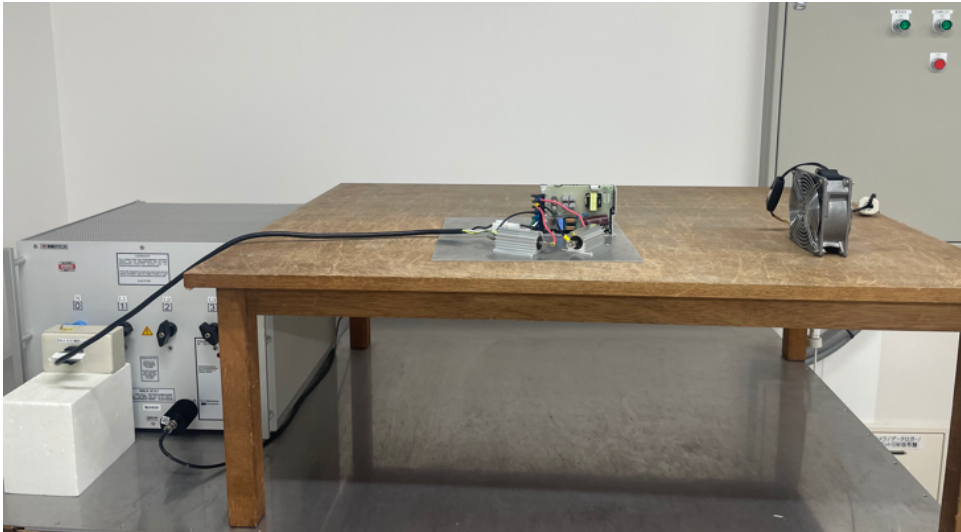




Conditions

Test : EMI
Model Name : PDW50F-12

1. Line conduction



2. Radiated emission

